

Search Notes

Application/Control No.

10/696,203

Examiner

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Applicant(s)/Patent under
Reexamination

HANSON ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	19	1/5/2006	JSL
716	21	1/5/2006	JSL
716	4	1/5/2006	JSL
716	2	1/5/2006	JSL
716	1	1/5/2006	JSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB)	1/5/2006	JSL
IEEE	1/5/2006	JSL